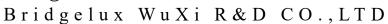
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650V 20A N-Channel Enhancement Mode Power MOSFET

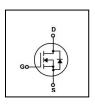
General Description

BXP20N65 is Bridgelux high voltage MOSFET family based on advanced planar DMOS technology. This advanced MOSFET family has optimized on-state resistance, and also provides superior switching performance and higher avalanche energy strength. This device family is suitable for high efficiency switch mode power supplies.

FEATURES

- RDSON≤0.4 Ω @Vgs=10V, Id=10A
- Low Crss
- · Ultra Low gate Charge
- · Fast switching capability
- · Improved dv/dt capability

SYMBOL







TO-220

TO-220F

ASSEMBLY MESSAGE

Product Name	Package	Packaging
BXP20N65P	TO-220	Tube
BXP20N65F	TO-220F	Tube

ABSOLUTE MAXIMUM RATINGS (T_C=25°C unless otherwise noted)

Parameter		Complete	Rating		I I m i 4
		Symbol	BXP20N65P	BXP20N65F	Unit
Drain-Source Voltage		V _{DSS}	650		V
Drain Current	Continuous (T _C = 25°C)		20		А
Drain Current	Continuous (T _C = 100°C)	l _D	13		Α
Drain Current	Pulsed (Note1)	I _{DM}	80		Α
Gate-Source Voltage		V _{GSS}	±30		V
Avalanche Energy Single Pulse (Note2)		E _{AS}	1350		mJ
Avalanche Current (Note1)		I AR	3.2		А
Peak Diode Recovery dv/dt (Note3)		dv/dt	5		V/ns
Power Dissipation (Note	T _C =25°C	Б	235.8	80	W
2)	Derate above 25°C	- P _D	1.89	0.64	W/°C
Maximum Junction Temperature		TJ	150		°C
Storage Temperature Range		T _{STG}	-55 to 150		°C

Note:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature
- 2. L=10mH, V_{DD} =50V, RG=25 Ω , Starting TJ = 25°C
- 3. $I_{SD} \le 20A$, $di/dt \le 200A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting TJ = 25°C



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THERMAL CHARACTERISTICS

Parameter	Symbol	Ma	Unit	
		BXP20N65P	BXP20N65F	Offic
Thermal Resistance, Junction-to-Case	R _{θJC}	0.53	1.56	°C / W

ELECTRICAL CHARACTERISTICS (T_J=25°C,unless otherwise Noted)

Parameter	Symbol	Test Condition	Min.	Тур.	Max.	Unit
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV _{DSS}	VGS=0V, ID=250μA	650			V
7 0 1 1/1 5 1 0 1	I _{DSS}	VDS=650V, VGS=0V			1	uA
Zero Gate Voltage Drain Current		VDS=520V, TC = 125°C			100	uA
Gate-Body Leakage Current, Forward		VGS=30V			100	nA
Gate-Body Leakage Current, Reverse	I _{GSS}	VGS=-30V			-100	nA
Breakdown Voltage Temperature	△BVDSS/	ID = 250 μA		0.5		V/°C
Coefficient	∆TJ			0.5		V/C
ON CHARACTERISTICS						
Gate Threshold Voltage	$V_{GS(TH)}$	VDS=VGS, ID=250μA	2	3	4	V
Drain-Source On-State Resistance	R _{DS(ON)}	VGS=10V, ID=10A		0.35	0.4	Ω
Forward Trans conductance (Note4)	g FS	VDS = 15V, ID=10A		17		S
DYNAMIC PARAMETERS						
Input Capacitance	Cıss	\/DQ_QF\/_\/QQ_Q\\/		2560		pF
Output Capacitance	Coss	VDS=25V, VGS=0V, f=1.0MHz		420		pF
Reverse Transfer Capacitance	Crss	1-1.0IVII 12		50		pF
SWITCHING PARAMETERS						
Turn-ON Delay Time	t _{D(ON)}	VDD-335V ID-304 VCS		40		ns
Turn-ON Rise Time	t _R	VDD=325V, ID=20A, VGS = 10V ,RG=25Ω		90		ns
Turn-OFF Delay Time	t _{D(OFF)}	(Note4,5)		188		ns
Turn-OFF Fall-Time	t _F	(110(64,5)		80		ns
Total Gate Charge(Note5)	Q_{G}	VDD =325V, VGS =10V, ID		61		nC
Gate Source Charge	Q _{GS}	=20A		13		nC
Gate Drain Charge	Q_{GD}	(Note4,5)		24		nC
SOURCE- DRAIN DIODE RATINGS	AND CHARA	ACTERISTICS				
Drain-Source Diode Forward Voltage	V_{SD}	IS=20A, VGS=0V			1.5	V
Diode Continuous Forward Current	Is				20	Α
Pulsed Drain-Source Current	I _{SM}				80	Α
Reverse Recovery Time	t _{RR}	VGS = 0 V, ISD = 20A		410		ns
Reverse Recovery Charge	Q _{RR}	di/dt=100 A/µs (Note4,5)		3.9		uC

Note: 4. Pulse Test : Pulse width ≤ 300µs, Duty cycle ≤ 2%

5. Essentially independent of operating temperature



TYPICAL CHARACTERISTICS

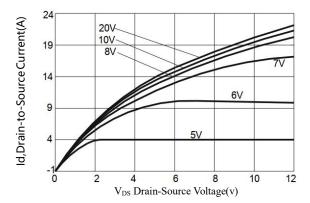


Figure 1. Typical Output Characteristics

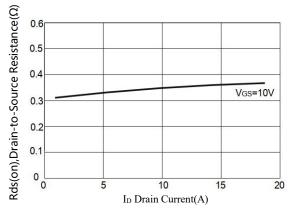


Figure 3. On-Resistance versus Drain Current

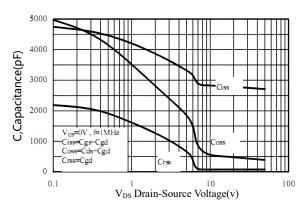


Figure 5. Typical Capacitance versus V_{DS}

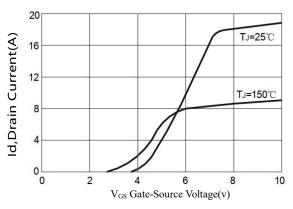


Figure 2. Typical Transfer Characteristics

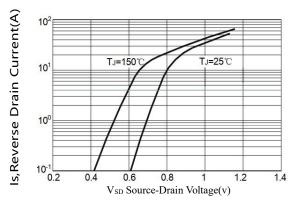


Figure 4. Diode forward voltage versus Current

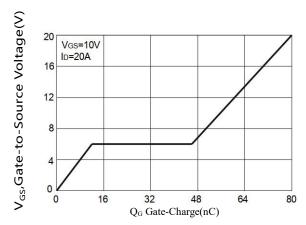


Figure 6. Typical Gate Charge versus V_{GS}



TYPICAL CHARACTERISTICS(Cont.)

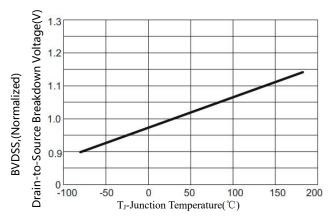


Figure 7. BV_{DSS} Variation with Temperature

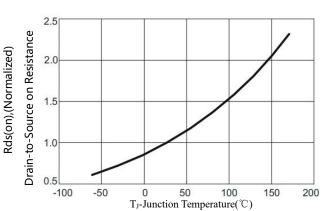


Figure 8. On-Resistance Variation with Temperature

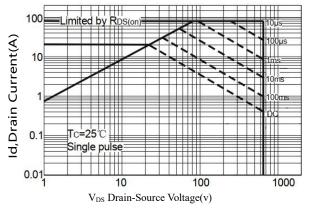


Figure 9. Maximum Safe Operating Area BXP20N65P

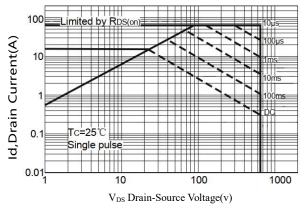


Figure 10. Maximum Safe Operating Area BXP20N65F

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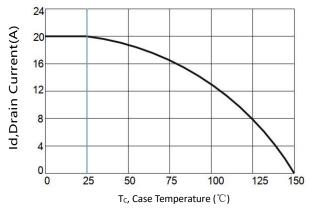
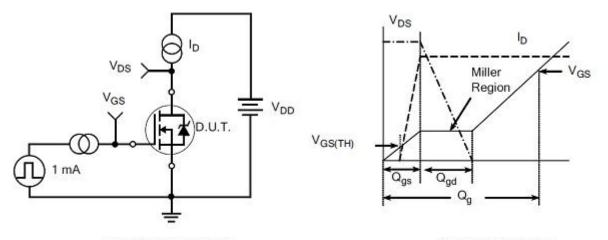


Figure 10. Maximum Continuous Drain Current versus Case Temperature

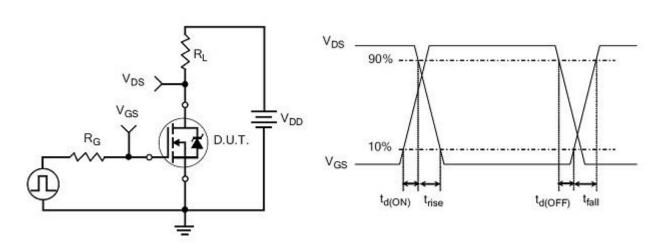


TEST CIRCUITS AND WAVEFORMS



Gate Charge Test Circuit

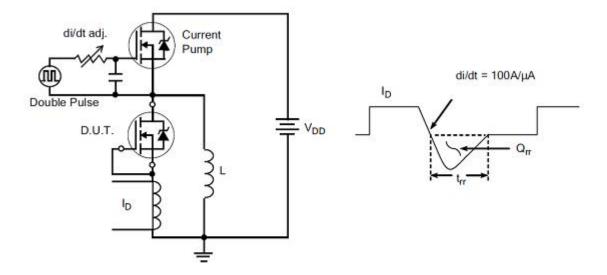
Gate Charge Waveform



Resistive Switching Test Circuit

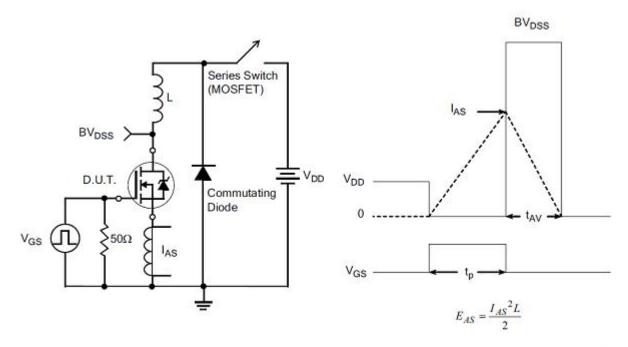
Resistive Switching Waveforms

TEST CIRCUITS AND WAVEFORMS(Cont.)



Diode Reverse Recovery Test Circuit

Diode Reverse Recovery Waveform



Unclamped Inductive Switching Test Circuit

Unclamped Inductive Switching Waveforms





Version: 1.0

Revision history

Document revision history

Date	Revision	Changes
17-Jan-2022	1.0	First release



Bridgelux WuXi R&D CO.,LTD



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